## INTEGRATED CIRCUITS



Product specification

1990 Oct 04

IC15 Data Handbook



PHILIPS

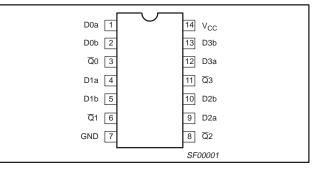
74F00

## FEATURE

Industrial temperature range available (-40°C to +85°C)

| TYPE  | TYPICAL<br>PROPAGATION<br>DELAY | TYPICAL<br>SUPPLY CURRENT<br>(TOTAL) |
|-------|---------------------------------|--------------------------------------|
| 74F00 | 3.4ns                           | 4.4mA                                |

#### **PIN CONFIGURATION**



#### **ORDERING INFORMATION**

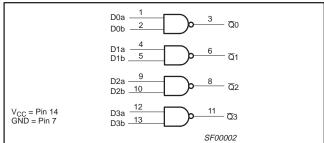
|                    | c   | ORDER CODE   |           |
|--------------------|---|--|-----------|
| DESCRIPTION        | COMMERCIAL RANGE $V_{CC}$ = 5V ±10%, $T_{amb}$ = 0°C to +70°C | INDUSTRIAL RANGE<br>V <sub>CC</sub> = 5V ±10%, T <sub>amb</sub> = −40°C to +85°C | PKG DWG # |
| 14-pin plastic DIP | N74F00N   | I74F00N  | SOT27-1   |
| 14-pin plastic SO  | N74F00D   | I74F00D  | SOT108-1  |

## INPUT AND OUTPUT LOADING AND FAN OUT TABLE

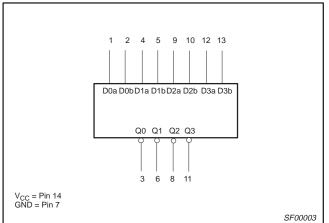
| PINS     | DESCRIPTION | 74F (U.L.) HIGH/LOW | LOAD VALUE HIGH/LOW |
|----------|-------------|---------------------|---------------------|
| Dna, Dnb | Data inputs | 1.0/1.0             | 20µA/0.6mA          |
| Qn       | Data output | 50/33               | 1.0mA/20mA          |

NOTE: One (1.0) FAST unit load is defined as:  $20\mu A$  in the high state and 0.6mA in the low state.

### LOGIC DIAGRAM



## LOGIC SYMBOL



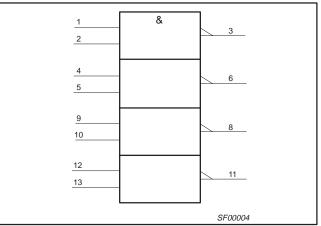
## **FUNCTION TABLE**

| INP | UTS | OUTPUT |
|-----|-----|--------|
| Dna | Dnb | Qn     |
| L   | L   | Н      |
| L   | Н   | Н      |
| Н   | L   | Н      |
| Н   | Н   | L      |

## NOTES:

H = High voltage level L = Low voltage level

#### **IEC/IEEE SYMBOL**



74F00

#### **ABSOLUTE MAXIMUM RATINGS**

(Operation beyond the limit set forth in this table may impair the useful life of the device.

Unless otherwise noted these limits are over the operating free air temperature range.)

| SYMBOL           | PARAMETER                                      |                  | RATING           | UNIT |
|------------------|--|------------------|------------------|------|
| V <sub>CC</sub>  | Supply voltage                                 |                  | -0.5 to +7.0     | V    |
| V <sub>IN</sub>  | Input voltage                                  |                  | -0.5 to +7.0     | V    |
| I <sub>IN</sub>  | Input current                                  |                  | -30 to +5        | mA   |
| V <sub>OUT</sub> | Voltage applied to output in high output state |                  | –0.5 to $V_{CC}$ | V    |
| I <sub>OUT</sub> | Current applied to output in low output state  |                  | 40               | mA   |
| T <sub>amb</sub> | Operating free air temperature range           | Commercial range | 0 to +70         | °C   |
|                  |  | Industrial range | -40 to +85       | °C   |
| T <sub>stg</sub> | Storage temperature range                      |                  | -65 to +150      | °C   |

## **RECOMMENDED OPERATING CONDITIONS**

| SYMBOL           | PARAMETER                            |                  |     | UNIT |     |    |
|------------------|--------------------------------------|------------------|-----|------|-----|----|
|                  |                                      |                  | MIN | NOM  | MAX |    |
| V <sub>CC</sub>  | Supply voltage                       |                  | 4.5 | 5.0  | 5.5 | V  |
| V <sub>IH</sub>  | High-level input voltage             |                  | 2.0 |      |     | V  |
| VIL              | Low-level input voltage              |                  |     | 0.8  | V   |    |
| l <sub>lk</sub>  | Input clamp current                  |                  |     |      | -18 | mA |
| I <sub>OH</sub>  | High-level output current            |                  |     |      | -1  | mA |
| I <sub>OL</sub>  | Low-level output current             |                  |     |      | 20  | mA |
| T <sub>amb</sub> | Operating free air temperature range | Commercial range | 0   |      | +70 | °C |
|                  |                                      | Industrial range | -40 |      | +85 | °C |

## DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

| SYMBOL          | PARAMETER                        |                  | TEST CONDITIO                | TEST CONDITIONS <sup>1</sup> |     |                  |      | UNIT |
|-----------------|----------------------------------|------------------|------------------------------|------------------------------|-----|------------------|------|------|
|                 |                                  |                  |                              |                              | MIN | TYP <sup>2</sup> | MAX  |      |
| V <sub>OH</sub> | High-level output voltage        |                  | $V_{CC} = MIN, V_{IL} = MAX$ | ±10%V <sub>CC</sub>          | 2.5 |                  |      | V    |
|                 |                                  |                  | $V_{IH} = MIN, I_{OH} = MAX$ | ±5%V <sub>CC</sub>           | 2.7 | 3.4              |      | V    |
| V <sub>OL</sub> | Low-level output voltage         |                  | $V_{CC} = MIN, V_{IL} = MAX$ | ±10%V <sub>CC</sub>          |     | 0.30             | 0.50 | V    |
|                 |                                  |                  | $V_{IH} = MIN, I_{OI} = MAX$ | ±5%V <sub>CC</sub>           |     | 0.30             | 0.50 | V    |
| V <sub>IK</sub> | Input clamp voltage              |                  | $V_{CC} = MIN, I_I = I_{IK}$ |                              |     | -0.73            | -1.2 | V    |
| l <sub>l</sub>  | Input current at maximum voltage | input            | $V_{CC} = MAX, V_I = 7.0V$   |                              |     |                  | 100  | μΑ   |
| I <sub>IH</sub> | High-level input current         |                  | $V_{CC} = MAX, V_I = 2.7V$   |                              |     |                  | 20   | μΑ   |
| IIL             | Low-level input current          |                  | $V_{CC} = MAX, V_I = 0.5V$   |                              |     |                  | -0.6 | mA   |
| I <sub>OS</sub> | Short-circuit output curren      | ıt <sup>3</sup>  | $V_{CC} = MAX$               |                              | -60 |                  | -150 | mA   |
| I <sub>CC</sub> | Supply current (total)           | I <sub>CCH</sub> | $V_{CC} = MAX$               |                              | 1.9 | 2.8              | mA   |      |
|                 |                                  | I <sub>CCL</sub> | V <sub>CC</sub> = MAX        |                              | 6.8 | 10.2             | mA   |      |

#### NOTES:

1. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type. 2. All typical values are at  $V_{CC} = 5V$ ,  $T_{amb} = 25^{\circ}C$ .

3. Not more than one output should be shorted at a time. For testing IOS, the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting of a high output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, I<sub>OS</sub> tests should be performed last.

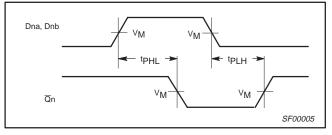
74F00

## **AC ELECTRICAL CHARACTERISTICS**

|                                      |                                     |                   |            |   |            | LIM  | ITS        |   |            |      |
|--------------------------------------|-------------------------------------|-------------------|------------|---|------------|--|------------|---|------------|------|
| SYMBOL                               | PARAMETER                           | TEST<br>CONDITION | Tai        | $V_{CC} = +5.0V$<br>$T_{amb} = +25^{\circ}C$<br>$C_{L} = 50pF, R_{L} = 500\Omega$ |            | $\label{eq:V_CC} \begin{split} V_{CC} &= +5.0V \pm 10\% \\ T_{amb} &= 0^{\circ}\text{C to} + 70^{\circ}\text{C} \\ C_L &= 50\text{pF}, \ R_L &= 500\Omega \end{split}$ |            | $V_{CC} = +5.0V \pm 10\% \\ T_{amb} = -40^{\circ}C \text{ to } +85^{\circ}C \\ C_L = 50pF, R_L = 500\Omega$ |            | UNIT |
|                                      |                                     |                   | MIN        | TYP   | MAX        | MIN  | MAX        | MIN   | MAX        |      |
| t <sub>PLH</sub><br>t <sub>PHL</sub> | Propagation delay<br>Dna, Dnb to Qn | Waveform 1        | 2.4<br>2.0 | 3.7<br>3.2  | 5.0<br>4.3 | 2.4<br>2.0   | 6.0<br>5.3 | 2.0<br>1.5  | 6.5<br>6.0 | ns   |

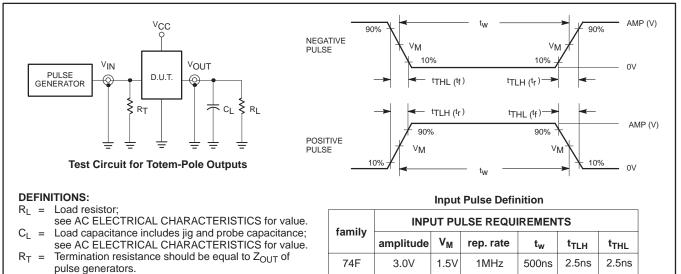
### **AC WAVEFORMS**

For all waveforms,  $V_M = 1.5V$ .



Waveform 1. Propagation delay for inverting outputs

## **TEST CIRCUIT AND WAVEFORM**



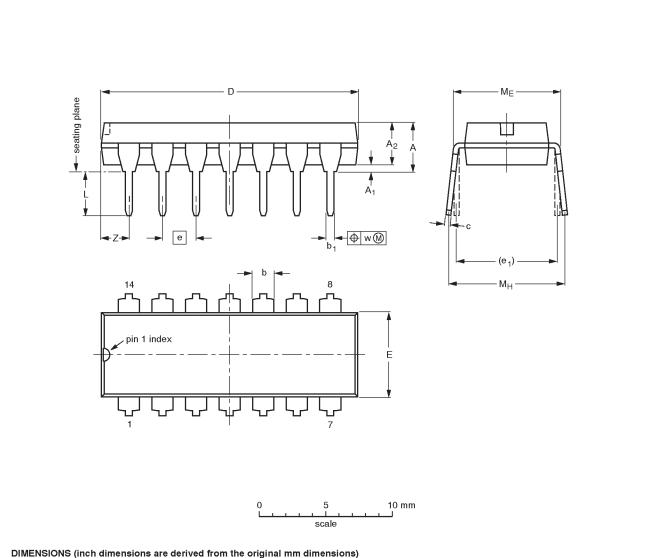
SF00006

**Philips Semiconductors** 

## 74F00

SOT27-1





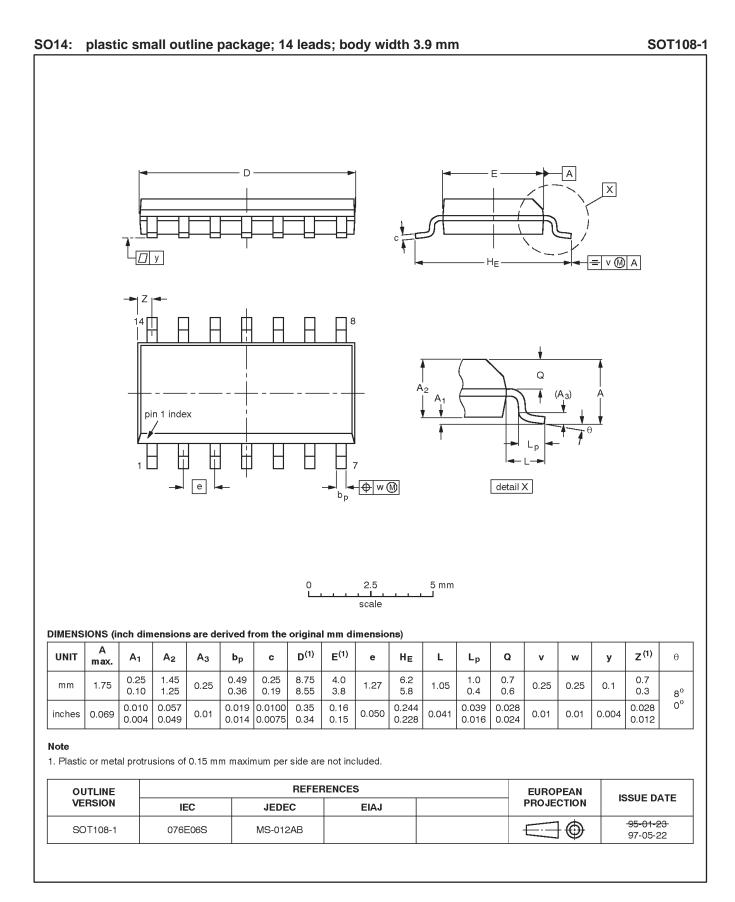
| UNIT   | A<br>max. | A <sub>1</sub><br>min. | A <sub>2</sub><br>max. | b              | b <sub>1</sub> | c              | D <sup>(1)</sup> | E <sup>(1)</sup> | e    | e <sub>1</sub> | L            | M <sub>E</sub> | M <sub>H</sub> | w     | Z <sup>(1)</sup><br>max. |
|--------|-----------|------------------------|------------------------|----------------|----------------|----------------|------------------|------------------|------|----------------|--------------|----------------|----------------|-------|--------------------------|
| mm     | 4.2       | 0.51                   | 3.2                    | 1.73<br>1.13   | 0.53<br>0.38   | 0.36<br>0.23   | 19.50<br>18.55   | 6.48<br>6.20     | 2.54 | 7.62           | 3.60<br>3.05 | 8.25<br>7.80   | 10.0<br>8.3    | 0.254 | 2.2                      |
| inches | 0.17      | 0.020                  | 0.13                   | 0.068<br>0.044 | 0.021<br>0.015 | 0.014<br>0.009 | 0.77<br>0.73     | 0.26<br>0.24     | 0.10 | 0.30           | 0.14<br>0.12 | 0.32<br>0.31   | 0.39<br>0.33   | 0.01  | 0.087                    |

#### Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

| OUTLINE |        | REFER    | EUROPEAN | ISSUE DATE |            |                                  |  |
|---------|--------|----------|----------|------------|------------|----------------------------------|--|
| VERSION | IEC    | JEDEC    | EIAJ     |            | PROJECTION | ISSUE DATE                       |  |
| SOT27-1 | 050G04 | MO-001AA |          |            |            | <del>-92-11-17</del><br>95-03-11 |  |

## 74F00



#### 1990 Oct 04

74F00

NOTES

74F00

#### Data sheet status

| Data sheet<br>status      | Product<br>status | Definition [1]  |
|---------------------------|-------------------|---|
| Objective specification   | Development       | This data sheet contains the design target or goal specifications for product development.<br>Specification may change in any manner without notice.  |
| Preliminary specification | Qualification     | This data sheet contains preliminary data, and supplementary data will be published at a later date.<br>Philips Semiconductors reserves the right to make chages at any time without notice in order to<br>improve design and supply the best possible product. |
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[1] Please consult the most recently issued datasheet before initiating or completing a design.

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